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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10517213 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>YAMANE, MITOKU |
|  | <b>Examiner</b><br><br>Quoc A Tran             | <b>Art Unit</b><br><br>2176  |

| SEARCHED |          |           |          |
|----------|----------|-----------|----------|
| Class    | Subclass | Date      | Examiner |
| 715      | 262, 700 | 3/27/2008 | QT       |
| 455      | 90.3     | 3/27/2008 | QT       |
| 341      | 28       | 3/27/2008 | QT       |
| 345      | 168-169  | 3/27/2008 | QT       |
| 704      | 2        | 3/27/2008 | QT       |

| SEARCH NOTES   |           |          |
|--|-----------|----------|
| Search Notes   | Date      | Examiner |
| EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO, DERWENT & IBM_TDB)  | 3/27/2008 | QT       |
| Inventors Searched Conducted- Considered Double Patent Rejection | 3/27/2008 | QT       |
| NPL Search (ACM Digital Library)                                 | 3/27/2008 | QT       |
| Text Search Class 715/262, 700; 455/All; 345/168-169; 704/2;     | 3/27/2008 | QT       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |